

OPA817 800MHz, High-Precision, Unity-Gain Stable, FET-Input Operational Amplifier

1 Features

- Wide bandwidth:
 - Gain-bandwidth product: 400MHz
 - Bandwidth (G = 1V/V): 800MHz
 - Large-signal bandwidth (2V_{PP}): 250MHz
 - Slew rate: 1000V/µs
- High precision:
 - Input offset voltage: 250µV (maximum)
 - Input offset voltage drift: 3.5µV/°C (maximum)
- Input voltage noise: 4.5nV/√Hz
- Input bias current: 2pA
- Low distortion (R_I = 100Ω , V_O = $2V_{PP}$):
 - HD2, HD3 at 10MHz: -86dBc, -100dBc
- Supply range: 6V to 12.6V
- Supply current: 23.5mA
- Shutdown current: 55µA
- Performance upgrade to OPA656

2 Applications

- High-speed data acquisition (DAQ)
- Active probes
- Oscilloscopes
- Wideband transimpedance amplifiers (TIAs)
- Wafer scanning equipment
- Optical communication modules
- Optical time-domain reflectometry (OTDR)
- Test and measurement front-ends
- Medical and chemical analyzers

3 Description

The OPA817 is a unity-gain stable, voltage-feedback operational amplifier for high-speed, high-precision and wide dynamic range applications.

The OPA817 has a low-noise junction gate fieldeffect transistor (JFET) input stage that features a wide gain-bandwidth of 400MHz and a supply range from 6V to 12.6V. The fast slew rate of 1000V/µs allows a wide large-signal bandwidth and low distortion when used as high impedance buffer in high-speed digitizers, active probes and other test and measurement applications.

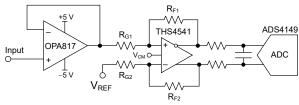
The OPA817 offers extremely low input offset voltage of ±250-µV and offset voltage drift of ±3.5µV/°C. The combination of pico-amperes of input bias current and low input voltage noise (4.5nV/\(\sqrt{Hz}\)) makes the OPA817 an excellent choice as a wideband transimpedance amplifier in optical test and communication equipment, as well as medical and scientific instrumentation.

The OPA817 is available in an 8-lead WSON package with an exposed thermal pad for heat dissipation. This device is specified to operate over the industrial temperature range of -40°C to +105°C.

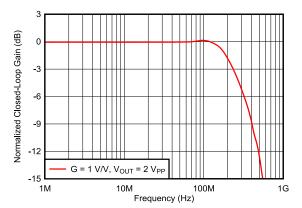
Package Information

| PART NUMBER ⁽¹⁾ | PACKAGE ⁽²⁾ | PACKAGE SIZE |
|----------------------------|------------------------|--------------|
| OPA817 | DTK (WSON, 8) | 3mm × 3mm |

- See Section 4.
- For more information, see Section 11.



High Input Impedance Digitizer Front-End



Large-Signal Frequency Response



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4 Device Comparison Table

| DEVICE | SUPPLY VOLTAGE (V) | BW (MHz) | INPUT | SLEW RATE (V/µs) | VOLTAGE NOISE (nV/√Hz) | MINIMUM STABLE GAIN (V/V) |
|---------|-----------------------|----------|-------|------------------|------------------------|------------------------------|
| OPA817 | ±6.3 | 400 | FET | 1000 | 4.5 | 1 |
| OPA818 | ±6.5 | 2700 | FET | 1400 | 2.2 | 7 |
| OPA657 | ±5 | 1600 | FET | 700 | 4.8 | 7 |
| OPA656 | ±5 | 230 | FET | 290 | 7 | 1 |
| OPA659 | ±6 | 350 | FET | 2550 | 8.9 | 1 |
| OPA858 | ±2.5 | 5500 | CMOS | 2000 | 2.5 | 7 |
| THS4631 | ±15 | 210 | FET | 1000 | 7 | 1 |

5 Pin Configuration and Functions

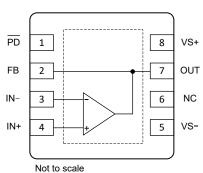


Figure 5-1. DTK Package, 8-Pin WSON With Thermal Pad (Top View)

Table 5-1. Pin Functions

| P | PIN | | PIN | | DESCRIPTION |
|-------------|-----|--------|--|--|-------------|
| NAME | NO. | ITPE | DESCRIPTION | | |
| FB | 2 | Output | Feedback resistor connection (optional) | | |
| IN- | 3 | Input | Inverting input | | |
| IN+ | 4 | Input | Noninverting input | | |
| NC | 6 | _ | No connect (no internal connection to die) | | |
| OUT | 7 | Output | Output of amplifier | | |
| PD | 1 | Input | Power down Low = amplifier disabled, High = amplifier enabled, Internal 2-M Ω pullup allows floating this pin | | |
| VS- | 5 | Power | Negative power supply | | |
| VS+ | 8 | Power | Positive power supply | | |
| Thermal pad | | _ | Electrically isolated from the die substrate. The thermal pad can be connected to any potential between the device power supplies. However, best practice is to connect the thermal pad to a heat-spreading plane, typically ground. | | |



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

| | | MIN | MAX | UNIT |
|------------------|--|-------------------|-----------------|------|
| Vs | Total supply voltage (V _{S+} - V _{S-}) | | 13 | V |
| | Maximum dV _S /dT for supply turn-on and turn-off ⁽²⁾ | | 1 | V/µs |
| VI | Input voltage | V _{S-} | V _{S+} | V |
| V _{ID} | Differential input voltage | | ±V _S | V |
| I _I | Continuous input current | | ±10 | mA |
| Io | Continuous output current ⁽³⁾ | | ±30 | mA |
| | Continuous power dissipation | See Thermal Infor | mation | |
| TJ | Maximum junction temperature | | 150 | °C |
| T _A | Operating free-air temperature | -40 | 105 | °C |
| T _{stg} | Storage temperature | -65 | 125 | °C |

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

- (2) To keep the edge-triggered ESD absorption devices across the supply pins off, do not exceed this specification.
- (3) Long-term continuous current for electromigration limits.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|---------------|---|-------|------|
| V | Electrostatic | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 | \/ |
| V _(ESD) | discharge | Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾ | ±1500 | V |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | MIN | NOM | MAX | UNIT |
|-------------------|----------------------|-----|-----|------|------|
| $V_{S+} - V_{S-}$ | Total supply voltage | 6 | 10 | 12.6 | V |
| T _A | Ambient temperature | -40 | 25 | 105 | °C |

6.4 Thermal Information

| | | OPA817 | |
|-----------------------|--|------------|------|
| | THERMAL METRIC(1) | DTK (WSON) | UNIT |
| | | 8 PINS | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 64.9 | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | 53.0 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 32.8 | °C/W |
| Ψ_{JT} | Junction-to-top characterization parameter | 1.3 | °C/W |
| Ψ_{JB} | Junction-to-board characterization parameter | 32.8 | °C/W |
| R _{θJC(bot)} | Junction-to-case (bottom) thermal resistance | 9.0 | °C/W |

 For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

Product Folder Links: OPA817



6.5 Electrical Characteristics

at $T_A \approx 25^{\circ}C$, $V_S = \pm 5$ V, G = 1 V/V, $R_F = 0$, $R_F = 250$ Ω for other gains, $R_L = 100$ Ω , and input and output referenced to mid-supply (unless otherwise noted)

| | ply (unless otherwise noted) PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------------------|---|---|--------|------|-------|--------|
| AC DED | FORMANCE | TEOT CONDITIONS | IVIIIV | | МАХ | Olti |
| AC PER | FORMANCE | \/ = 200 m\/ | | 900 | | |
| | | $V_{OUT} = 200 \text{ mV}_{PP}$ | | 800 | | |
| SSBW | Small-signal bandwidth | $V_{OUT} = 200 \text{ mV}_{PP}, G = 2 \text{ V/V}$ | | 400 | | MHz |
| | | V _{OUT} = 200 mV _{PP} , G = 5 V/V | | 100 | | |
| | | V _{OUT} = 200 mV _{PP} , G = 10 V/V | | 40 | | |
| GBWP | Gain-bandwidth product | V _{OUT} = 200 mV _{PP} , G = 100 V/V | | 400 | | MHz |
| LSBW | Large-signal bandwidth | $V_{OUT} = 2 V_{PP}$ | | 250 | | MHz |
| | | V _{OUT} = 4 V _{PP} | | 140 | | |
| | Bandwidth for 0.1-dB flatness | V _{OUT} = 2 V _{PP} | | 100 | | MHz |
| SR | Slew rate (10% to 90%) | V _{OUT} = 4–V step | | 1000 | | V/µs |
| | Slew rate (10% to 90%) | V _{OUT} = 1–V step, Gain = 2 V/V | | 750 | | 77,40 |
| : _R , t _F | Rise, fall time | V _{OUT} = 200–mV step | | 0.7 | | ns |
| | Settling time to 0.1%, | V _{OUT} = 2–V step | | 6 | | ns |
| | Overshoot and undershoot | V _{OUT} = 2–V step | | 8 | | % |
| | Output Overdrive recovery time | $V_{OUT} = V_{S-}$ to V_{S+} , $G = 2 \text{ V/V}$, | | 15 | | ns |
| | | f = 1 MHz, V _{OUT} = 2 V _{PP} | | -110 | | |
| LIDO | Second-order harmonic distortion | f = 10 MHz, V _{OUT} = 2 V _{PP} | | -86 | | dBc |
| HD2 | | f = 50 MHz, V _{OUT} = 2 V _{PP} | | -76 | | |
| | | $f = 10 \text{ MHz}, V_{OUT} = 2 V_{PP}, R_L = 1 \text{ k}\Omega$ | | -97 | | |
| | Third-order harmonic distortion | f = 1 MHz, V _{OUT} = 2 V _{PP} | | -120 | | |
| | | f = 10 MHz, V _{OUT} = 2 V _{PP} | | -100 | | dBc |
| HD3 | | f = 50 MHz, V _{OUT} = 2 V _{PP} | | -68 | | |
| | | $f = 10 \text{ MHz}, V_{OUT} = 2 V_{PP}, R_L = 1 k\Omega$ | | -102 | | |
| | Input voltage noise | f ≥ 200 kHz | | 4.5 | | nV/√Hz |
| PN | Voltage noise 1/f corner frequency | | | 2.6 | | kHz |
| | Input current noise | | | 18 | | fA/√Hz |
| OC PER | FORMANCE | | | | | |
| | | V _{OUT} = ±1 V | 78 | 85 | | |
| A _{OL} | Open-loop voltage gain | $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ | 72 | | | dB |
| OL | open loop voltage gain | $T_A = -40^{\circ} \text{C to } +105^{\circ} \text{C}$ | 69 | | | ub. |
| | | 1 _A 40 0 to 1100 0 | | 50 | ±250 | |
| Vos | Input-referred offset voltage | T _A = -40°C to +85°C | | | ±500 | μV |
| /os | input-referred onset voltage | | | | | μν |
| | | $T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$ | | 4 | ±600 | |
| | Input offset voltage drift | $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ | | 1 | ±3.5 | μV/°C |
| | | $T_A = -40^{\circ}C \text{ to } +105^{\circ}C$ | | 1 | ±3.5 | |
| | | | | 2 | ±20 | |
| В | Input bias current | $T_A = -40$ °C to +85°C | | | ±1000 | pA |
| | | $T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$ | | | ±1500 | |
| | | | | 1 | ±20 | |
| os | Input offset current | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ | | | ±500 | pA |
| | | $T_A = -40^{\circ}C \text{ to } +105^{\circ}C$ | | | ±750 | |
| | Internal feedback trace resistance | Device turned OFF, OUT to FB pin resistance | | 0.7 | | Ω |



6.5 Electrical Characteristics (continued)

at $T_A \approx 25^{\circ}$ C, $V_S = \pm 5$ V, G = 1 V/V, $R_F = 0$, $R_F = 250$ Ω for other gains, $R_L = 100$ Ω , and input and output referenced to

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------|--|--|-----|-----------|------|----------|
| INPUT | | | | | | |
| | | | 2.1 | 2.7 | | |
| | Most positive input voltage ⁽¹⁾ | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ | 2.0 | | | V |
| | | $T_A = -40^{\circ}C \text{ to } +105^{\circ}C$ | 2.0 | | | |
| | | | | -3.9 | -3.5 | |
| | Most negative input voltage ⁽¹⁾ | T _A = -40°C to +85°C | | | -3.4 | V |
| | | $T_A = -40^{\circ}C \text{ to } +105^{\circ}C$ | | | -3.4 | |
| | | V _{CM} = ±0.5 V | 84 | 110 | | |
| CMRR | Common-mode rejection ratio | T _A = -40°C to 85°C | 83 | | | dB |
| | | T _A = -40°C to 105°C | 82 | | | |
| | Input impedance common-mode | | | 60 2.9 | | GΩ pF |
| | Input capacitance differential mode | | | 0.1 | | pF |
| OUTPU | г | | | | | |
| | | no-load | | -3.9 | -3.6 | V |
| | Output voltage, low | R _L = 100 Ω | | -3.7 | -3.4 | |
| V _{OL} | | T _A = -40°C to +85°C | | | -3.3 | |
| | | $T_A = -40^{\circ}C \text{ to } +105^{\circ}C$ | | | -3.2 | |
| | | no-load | 3.7 | 3.9 | | V |
| | | R _L = 100 Ω | 3.4 | 3.7 | | |
| V_{OH} | Output voltage, high | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ | 3.3 | | | |
| | | $T_A = -40^{\circ}C \text{ to } +105^{\circ}C,$ | 3.2 | | | |
| | | $V_{OUT} = \pm 1 \text{ V}, \Delta V_{OS} < 2 \text{ mV}$ | ±58 | 80 | | |
| | Linear output drive (sourcing/sinking) | $T_A = -40 \text{ to } 85^{\circ}\text{C}, \ \Delta V_{OS} < 3 \text{ mV}$ | ±40 | | | mA |
| | | $T_A = -40 \text{ to } 105^{\circ}\text{C}, \Delta V_{OS} < 3 \text{ mV}$ | ±35 | | | |
| | Short-circuit current | | | ±100 | | mA |
| Z _O | Closed loop output Impedance | f = 100 kHz | | 0.04 | | Ω |
| POWER | SUPPLY | | | | | |
| | | | | 23.5 | 24.5 | |
| I _Q | Quiescent current | $T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ | | | 24.7 | mA |
| ~ | | $T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$ | | | 24.9 | |
| | | $\Delta V_{S+} = \pm 0.5 \text{ V}$ | 80 | 100 | | |
| PSRR+ | Power-supply rejection ratio | T _A = -40°C to +85°C | 77 | | | dB |
| | | $T_A = -40$ °C to +105°C | 76 | | | 1 |
| | | $\Delta V_{S_{-}} = \pm 0.5 \text{ V},$ | 80 | 100 | | |
| PSRR- | Power-supply rejection ratio | $T_A = -40^{\circ}\text{C to } +85^{\circ}\text{C}$ | 77 | | | dB |
| | r ower-supply rejection ratio | $T_A = -40^{\circ}\text{C to } +105^{\circ}\text{C}$ | 76 | | | |

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6.5 Electrical Characteristics (continued)

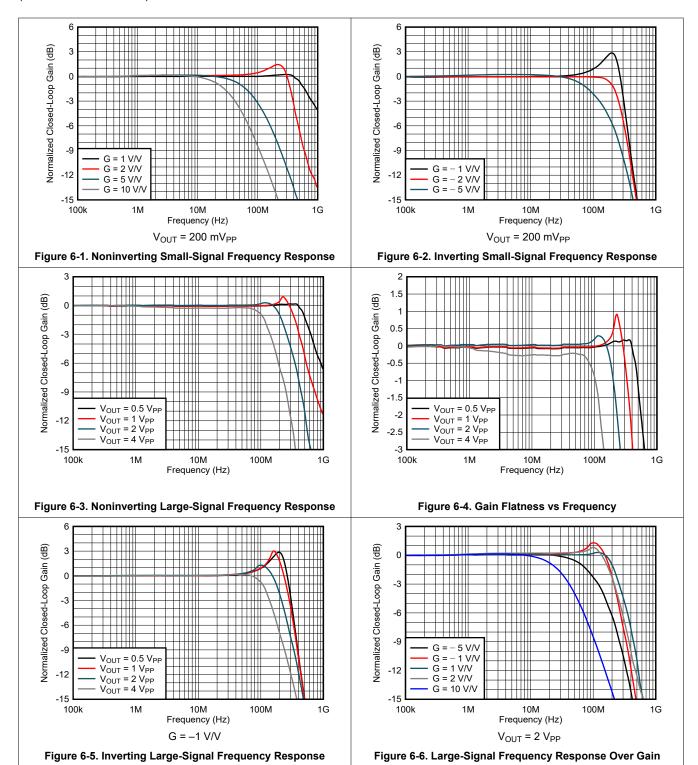
at $T_A \approx 25^{\circ}C$, $V_S = \pm 5$ V, G = 1 V/V, $R_F = 0$, $R_F = 250$ Ω for other gains, $R_L = 100$ Ω , and input and output referenced to mid-supply (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------|--|--|-----|-----|-----|------|
| POWER | DOWN | | | | | |
| | Enable voltage threshold | Specified <i>on</i> above (V _{S+}) – 1 V | | | 4 | V |
| | Disable voltage threshold | Specified off below (V _{S+}) – 3 V | 2 | | | V |
| | Power-down quiescent current | $\overline{PD} \le (V_{S+}) - 3V$ | | 55 | 100 | μΑ |
| | Power-down pin bias current in shutdown mode | PD = 0 V to (V _{S+}) – 3 V | | 9 | 12 | μΑ |
| | Power-down pin bias current in active mode | $\overline{PD} = (V_{S+}) - 1 \text{ V to } (V_{S+})$ | | 0.5 | 1 | μΑ |
| | Turn-on time delay | Time from \overline{PD} voltage exceeds threshold to V_{OUT} = 90% of final value, V_{IN} = 1V | | 0.3 | | μs |
| | Turn-off time delay | Time from \overline{PD} voltage reduces below threshold to I_Q = 10% of active mode value | | 0.1 | | μs |

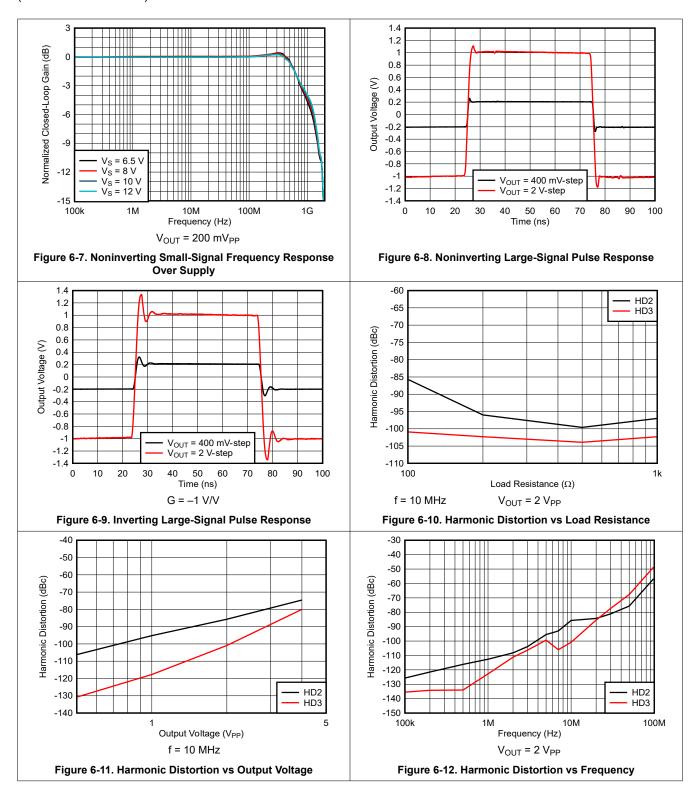
⁽¹⁾ Input range for CMRR > 77 dB.



6.6 Typical Characteristics: $V_S = \pm 5 \text{ V}$

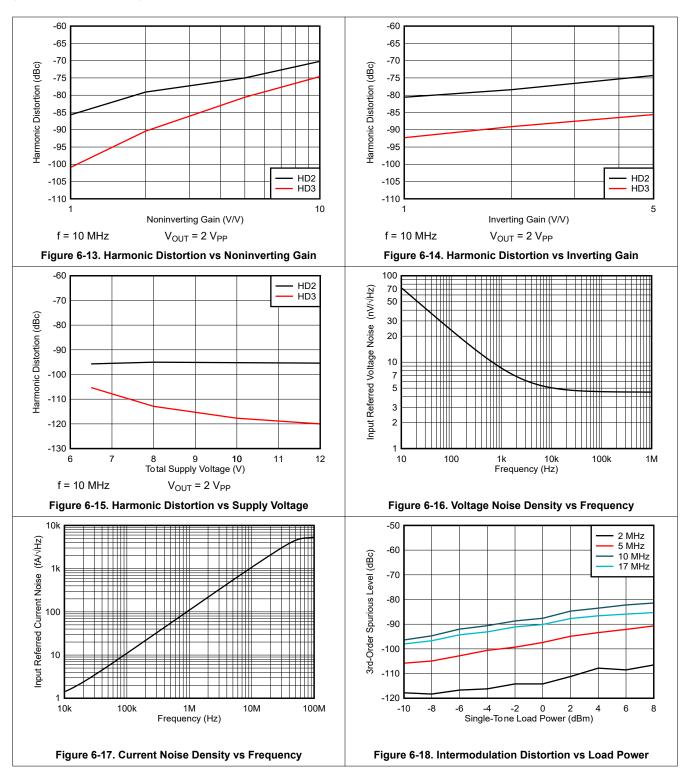


6.6 Typical Characteristics: $V_S = \pm 5 V$ (continued)

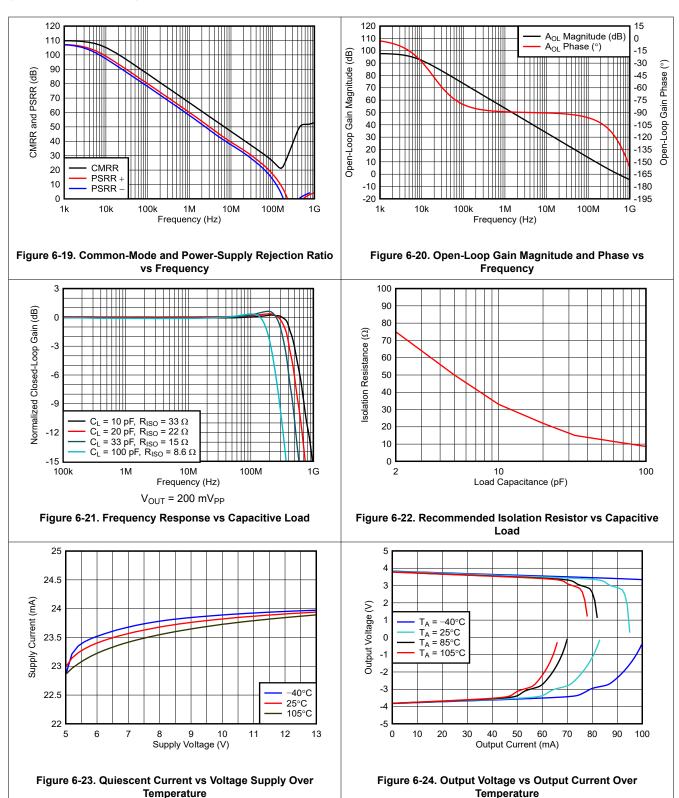




6.6 Typical Characteristics: $V_S = \pm 5 V$ (continued)



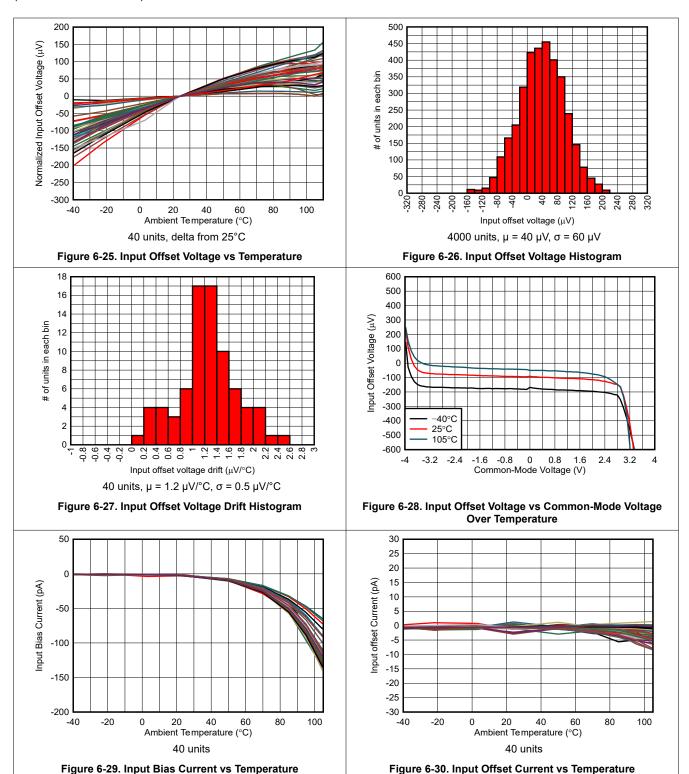
6.6 Typical Characteristics: V_S = ±5 V (continued)





6.6 Typical Characteristics: $V_S = \pm 5 \text{ V}$ (continued)

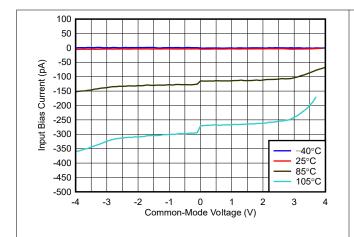
at G = 1 V/V, R_F = 0 Ω , R_F = 250 Ω for other gains, R_L = 100 Ω , input and output referenced to mid-supply, and $T_A \cong 25^{\circ}C$ (unless otherwise noted)



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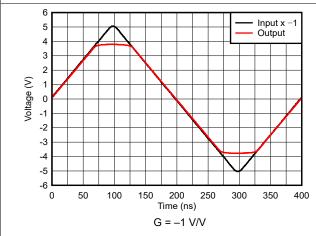
6.6 Typical Characteristics: $V_S = \pm 5 V$ (continued)



6 Voltage (V) -2 -6 Input x 2 -8 Output -10 0 50 100 150 200 250 300 350 Time (ns) G = 2 V/V

Figure 6-31. Input Bias Current vs Common-Mode Voltage Over Temperature

Figure 6-32. Noninverting Output Overdrive Recovery



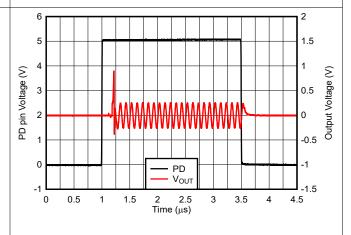


Figure 6-33. Inverting Output Overdrive Recovery

Figure 6-34. Turn-On and Turn-Off Waveform

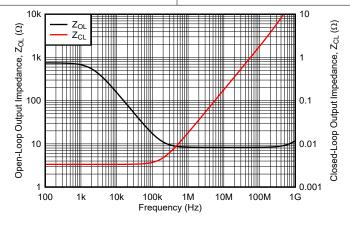


Figure 6-35. Open-Loop and Closed-Loop Output Impedance vs Frequency

7 Detailed Description

7.1 Overview

The OPA817 is a high-voltage, unity-gain-stable, 400-MHz gain-bandwidth product (GBWP), voltage-feedback operational amplifier (op amp) featuring a 4.5-nV/ $\sqrt{\text{Hz}}$, low-noise, JFET input stage. The low offset voltage (250 μ V maximum), offset voltage drift (3.5 μ V/°C maximum), and unity gain bandwidth of 800 MHz makes this device an excellent choice for high-input-impedance, high-speed, data-acquisition front-ends. The high voltage capability combined with 1000 V/ μ s slew rate enables applications needing wide output swings (9 V_{PP} at V_S = 12 V) for high-frequency signals such as those often found in medical instrumentation, optical front-end, test, and measurement applications. The low noise JFET input with pico-amperes of bias current makes the device attractive in high-gain TIA applications and in test and measurement front-ends. OPA817 also features a power-down mode that disables the core amplifier for power savings.

The OPA817 is built using Tl's proprietary high-voltage, high-speed, complementary bipolar SiGe process.

7.2 Functional Block Diagram

The OPA817 is a conventional voltage feedback op amp with two high-impedance inputs and a low-impedance output. Figure 7-1 and Figure 7-2 shows two standard amplifier configuration examples that are supported for this device. The reference voltage (V_{REF}) level shifts the dc operating point for each configuration, which is typically set to mid-supply in single-supply operation. V_{REF} is typically set to ground in split-supply applications.

$$V_{SIG}$$
 V_{REF}
 V_{IN}
 V_{S+}
 V_{OUT}
 V_{REF}
 V_{REF}

Figure 7-1. Noninverting Amplifier

$$V_{SIG}$$
 V_{REF}
 V_{NO}
 V_{NO}

Figure 7-2. Inverting Amplifier

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7.3 Feature Description

7.3.1 Input and ESD Protection

The OPA817 is built using a very high-speed complementary bipolar process. The internal junction breakdown voltages are relatively low for these very small geometry devices. These breakdowns are reflected in the *Absolute Maximum Ratings*. As Figure 7-3 shows, all device pins are protected with internal ESD protection diodes to the power supplies.

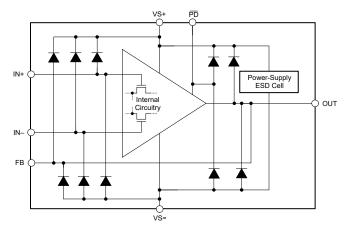


Figure 7-3. Internal ESD Protection

The diodes provide moderate protection to input overdrive voltages beyond the supplies as well. The protection diodes can typically support a 10-mA continuous current. Where higher currents are possible (for example, in systems with ± 12 -V supply parts driving into the OPA817), add current limiting series resistors in series with the two inputs to limit the current. Keep these resistor values as low as possible because high values degrade both noise performance and frequency response. There are no back-to-back ESD diodes between V_{IN+} and V_{IN-} . As a result, the differential input voltage between V_{IN+} and V_{IN-} is entirely absorbed by the V_{GS} of the input JFET differential pair and must not exceed the voltage ratings shown in the *Absolute Maximum Ratings*.

7.3.2 Feedback Pin

For high-speed analog design, minimizing parasitic capacitances and inductances is critical to get the best performance from a high-speed amplifier such as the OPA817. Parasitic capacitance and inductance are especially detrimental in the feedback path and at the inverting input, and result in undesired poles and zeroes in the feedback that can result in reduced phase margin or instability. Techniques used to correct this phase margin reduction often result in reduced application bandwidth. To keep system engineers from making these tradeoff choices and to simplify the PCB layout, OPA817 features an FB pin on the same side as the inverting input pin (IN–). Figure 7-4 shows how this feature allows for a very short feedback resistor (R_F) connection between the FB and the IN– pin, which minimizes parasitic capacitance and inductance with minimal PCB design effort. Internally the FB pin is connected to OUT pin through metal routing on the silicon. Because of the fixed metal sizing of this connection, the FB pin has limited current carrying capability. Therefore, the specifications in the Absolute Maximum Ratings section must be adhered to for continuous operation. For applications requiring high accuracy, the metal routing resistance from OUT to FB can be considered and added to R_F to set the desired gain. For more information, see Section 6.5.

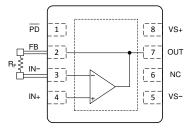


Figure 7-4. R_F Connection Between FB and IN- Pins

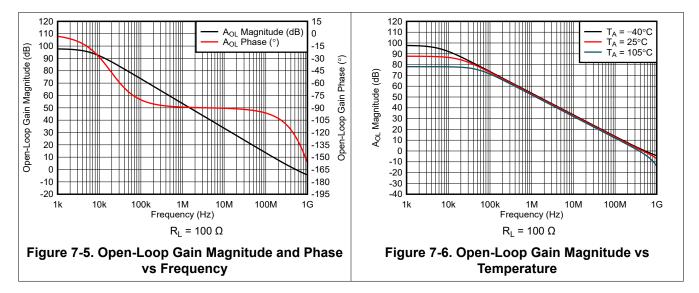
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7.3.3 FET-Input Architecture With Wide Gain-Bandwidth Product

Figure 7-5 shows the open-loop gain and phase response of the OPA817. The GBWP of an op amp is measured in the 20-dB/decade constant slope region of the A_{OL} magnitude plot. The open-loop gain of 60 dB for the OPA817 is along this 20-dB/decade slope, and the corresponding frequency intercept is at 400 kHz. Converting 60 dB to linear units (1000 V/V) and multiplying by the 400-kHz frequency intercept gives a GBWP of 400 MHz for the OPA817. The A_{OL} Bode plot shows that the second pole in the A_{OL} response occurs after A_{OL} magnitude drops to less than 0 dB (1 V/V). The location of second pole results in phase change of less than 180° at 0 dB A_{OL} , indicating that the amplifier is stable in a gain of 1 V/V. Amplifiers such as the OPA817 that are JFET-input, low noise and unity-gain stable can be used as high-input-impedance buffers and gain stages with minimal degradation in SNR. The device has 800 MHz of SSBW in a gain-of-1-V/V configuration with a phase margin of approximately 55°.

The low input offset voltage and offset voltage drift of OPA817 makes the device an excellent amplifier for high-precision, high-input-impedance, wideband, data-acquisition-system front-ends. Figure 8-2 shows that the system benefits from the low noise JFET input stage with pico-amperes of input bias current to achieve higher precision at 1-M Ω input impedance setting and higher SNR at 50- Ω input impedance setting simultaneously in a typical data-acquisition front-end circuit.



7.4 Device Functional Modes

7.4.1 Power-Down (PD) Pin

The OPA817 includes a power-down mode for low-power or standby operation and only consumes 55 μ A (typical) of current when placed in power-down mode. Low-power systems that are only active for small periods of time benefit from this feature. The OPA817 transitions from low-power mode to active-mode in 300 ns (typical). For power-down pin control thresholds, see also Section 6.5. An internal pull-up resistor of 2-M Ω provides a weak pull-up to V_{S+} if \overline{PD} is left unconnected. Use an external 1-nF capacitor to V_{S+} to avoid external noise coupling and false triggering. If the power-down mode is not used in an application, then connect the \overline{PD} pin to V_{S+} .

Product Folder Links: OPA817

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8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Wideband, High-Input-Impedance DAQ Front End

The OPA817 features a unique combination of high GBWP, low-input voltage noise, and the dc precision of a trimmed JFET-input stage to provide a high input impedance for a voltage-feedback amplifier. Figure 8-2 shows how the very high GBWP of 400 MHz and high large signal bandwidth of 250 MHz can be used to either deliver wide signal bandwidths at high gains or to extend the achievable bandwidth or gain in typical high-speed, high-input impedance data acquisition front-end applications. To achieve the full performance of the OPA817, careful attention to the printed circuit board (PCB) layout and component selection is required as discussed in the following sections of this data sheet. OPA817 also features a wider supply range thereby enabling a wider common-mode input range to support higher input signal swings.

Figure 8-1 shows the noninverting gain of +2 V/V circuit used as the basis for most of the *Typical Characteristics*. Most of the curves were characterized using signal sources with $50-\Omega$ driving impedance, and with measurement equipment presenting a $50-\Omega$ load impedance. As Figure 8-1 shows, the $49.9-\Omega$ shunt resistor at the V_{IN} terminal matches the source impedance of the test generator, while the $49.9-\Omega$ series resistor at the V_O terminal provides a matching resistor for the measurement equipment load. Generally, data sheet voltage swing specifications are at the output pin (V_O in Figure 8-1) while output power specifications are at the matched $50-\Omega$ load. As shown in Figure 8-1, the total $100-\Omega$ load at the output combined with the $250-\Omega$ total feedback network load presents the OPA817 with an effective output load of $83.3~\Omega$ for the circuit.

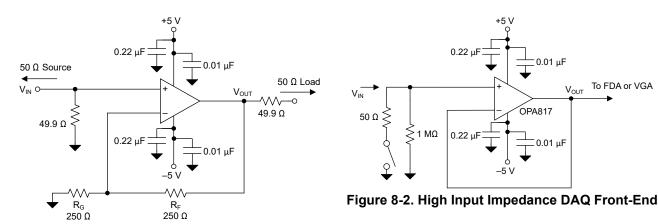


Figure 8-1. Noninverting G = +2 V/V Configuration and Test Circuit

Voltage-feedback operational amplifiers, unlike current feedback amplifiers, can use a wide range of resistor values to set the gain. As Figure 8-1 shows, always keep the parallel combination of $R_F \parallel R_G$ to a lower value to retain a controlled frequency response for the noninverting voltage amplifier. In the noninverting configuration, the parallel combination of $R_F \parallel R_G$ forms a pole with the parasitic input capacitance at the inverting node of the OPA817 (including layout parasitic capacitance). For best performance, ensure that this pole is at a frequency greater than the closed-loop bandwidth for the OPA817.



8.2 Typical Applications

8.2.1 High-Input-Impedance, 200-MHz, Digitizer Front-End Amplifier Design

The OPA817 offers a wide large-signal bandwidth, high-slew rate along with high-input impedance making this device an excellent choice for data-acquisition systems. The trimmed dc precision of the OPA817 enables direct use of the device as a front-end amplifier where low offset and offset voltage drift is needed.

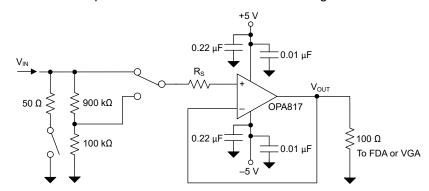


Figure 8-3. High-Input-Impedance, 200MHz, Digitizer Front-End Amplifier

8.2.1.1 Design Requirements

Table 8-1 lists the design requirements for a high-input-impedance, 200-MHz, digitizer front-end amplifier.

| Table 8-1. Design Requirements | | | |
|--|--|--|--|
| SPECIFICATION | VALUE | | |
| Input impedance | 1 ΜΩ / 50Ω | | |
| Input range (1 MΩ / 50 Ω) | 20 V _{PP} / 2 V _{PP} | | |
| Offset drift | 3.5 μV/°C maximum | | |
| Noise at highest resolution (50 O Input) | 80 uVpms | | |

Table 8-1. Design Requirements

8.2.1.2 Detailed Design Procedure

- Input Impedance: The JFET-input stage of the OPA817 offers gigaohms of input impedance, and therefore enables the front-end to be terminated with a 1-M Ω resistor while achieving excellent precision. A 50- Ω resistance can also be switched in offering matched termination for high-frequency signals. The OPA817, therefore, enables the designer to use both 1-M Ω and 50- Ω termination in the same signal chain.
- **Noise**: The total noise of the front-end amplifier is the function of the voltage and current noise of the OPA817, input termination, and the resistors thermal noise. In 50-Ω mode, the dominant noise source, however, is contributed by the voltage noise of the OPA817 as a result of noise being integrated over the complete bandwidth. Thus, the total RMS noise of the front-end amplifier is approximately equal to the voltage noise of OPA817 over 200 MHz.

The specified input referred voltage noise of the OPA817 is 4.5 nV/√Hz; see also Section 6.5. The total integrated RMS noise at the input in a bandwidth of 200 MHz is given by the following equation:

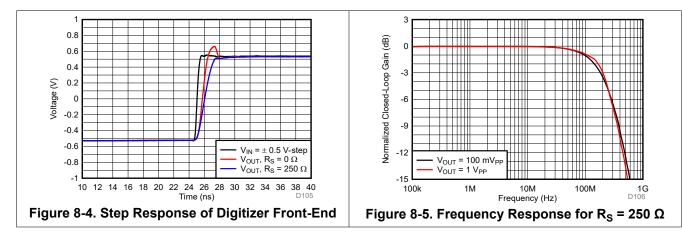
$$En_{RMS} = 4.5 \text{ nV}/\sqrt{Hz} \times \sqrt{(200 \text{ MHz} \times 1.57)} = 80 \mu V_{RMS}.$$
 (1)

The Brickwall correction factor of 1.57 is applied assuming the bandwidth is limited to 200 MHz with a single pole RC-filter before digitizing the signal with the ADC. Detailed calculations can be found at TI Precision Labs – Op Amps: Noise – Spectral Density.

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• Optimizing Overshoot: The OPA817 features an internal slew-boost circuit to deliver fast rise-time in applications needing high slew rates such as when configured as a transimpedance amplifier. For applications where overshoot needs to be limited, the input slew rates can be limited with introducing a series resistance (R_S) as shown in Figure 8-3. The resistance R_S forms a low pass filter with the input capacitance of approximately 2.6 pF at the noninverting pin of the OPA817 limiting the input slew rate to the amplifier. Figure 8-4 shows how limiting the input slew rate to the amplifier results in good overshoot performance, and Figure 8-5 shows how this achieves a small signal and large signal bandwidth of 200 MHz.

8.2.1.3 Application Curves



8.3 Power Supply Recommendations

The OPA817 is intended to operate on supplies ranging from 6 V to 12.6 V. OPA817 supports single-supply, split, balanced, and unbalanced bipolar supplies. When operating at supplies below 8 V, consideration must be given to the input common-mode range of the amplifier. Under these supply conditions, the common-mode must be biased appropriately for linear operation. Thus, the limit to lower supply voltage operation is the usable input voltage range for the JFET-input stage.

8.4 Layout

8.4.1 Layout Guidelines

Achieving optimized performance with a high-frequency amplifier such as the OPA817 requires careful attention to board layout parasitics and external component types. Recommendations that optimize performance include the following:

1. Minimize parasitic capacitance to any ac ground for all of the signal I/O pins. Parasitic capacitance on the output and inverting input pins can cause instability. On the noninverting input, parasitic capacitance can react with the source impedance to cause unintentional bandlimiting. Ground and power metal planes act as one of the plates of a capacitor while the signal trace metal acts as the other separated by PCB dielectric. To reduce this unwanted capacitance, take care to minimize the routing of the feedback network. A plane cutout around and underneath the inverting input pin on all ground and power planes is recommended. Otherwise, ensure that ground and power planes are unbroken elsewhere on the board.



- 2. **Minimize the distance (less than 0.25-in) from the power-supply pins to high-frequency decoupling capacitors.** Use high quality, 100-pF to 0.1-μF, C0G and NPO-type decoupling capacitors with voltage ratings at least three times greater than the amplifiers maximum power supplies to maintain a low-impedance path to the amplifiers power-supply pins across the amplifiers gain bandwidth specification. At the device pins, do not allow the ground and power plane layout to be in close proximity to the signal I/O pins. Avoid narrow power and ground traces to minimize inductance between the pins and the decoupling capacitors. Use larger (2.2-μF to 6.8-μF) decoupling capacitors, effective at lower frequency, on the supply pins. Place these capacitors further from the device and share the capacitors among several devices in the same area of the PCB.
- 3. Careful selection and placement of external components preserves the high frequency performance of the OPA817. Use low-reactance resistors. Surface-mount resistors work best and allow a tighter overall layout. Never use wirewound type resistors in a high frequency application. The output pin and inverting input pin are the most sensitive to parasitic capacitance; therefore, always position the feedback and series output resistor, if any, as close as possible to the inverting input and the output pin, respectively. Place other network components, such as noninverting input termination resistors, close to the package. Even with a low parasitic capacitance at the noninverting input, high external resistor values can create significant time constants that can degrade performance. When OPA817 is configured as a conventional voltage amplifier, keep the resistor values as low as possible and consistent with the load driving considerations. Decrease the resistor values to keep the resistor noise terms low and minimizes the effect of the parasitic capacitance. However, lower resistor values increase the dynamic power consumption because R_F and R_G become part of the output load network of the amplifier.
- 4. Heat dissipation is important for a high voltage device like the OPA817. For good thermal relief, connect the thermal pad to a heat-spreading plane that is preferably on the same layer as the OPA817, or connected by as many vias as possible if the plane is on a different layer. Have at least one heat-spreading plane on the same layer as the OPA817 that makes direct connection to the thermal pad with wide metal for good thermal conduction when operating at high ambient temperatures. If more than one heat-spreading plane is available, then connect the heat-spreading planes by a number of vias to further improve the thermal conduction.

8.4.1.1 Thermal Considerations

The OPA817 does not require a heat sink or airflow in most applications. The maximum allowed junction temperature sets the maximum allowed internal power dissipation as described in the following paragraph. Do not allow the maximum junction temperature to exceed 150°C.

Operating junction temperature (T_J) is given by $T_A + P_D \times R_{\theta JA}$. The total internal power dissipation (P_D) is the sum of quiescent power (P_{DQ}) and additional power dissipated in the output stage (P_{DL}) to deliver load power. Quiescent power is the specified no-load supply current times the total supply voltage across the part. P_{DL} depends on the required output signal and load, but for a grounded resistive load, P_{DL} is at a maximum when the output is fixed at a voltage equal to 1/2 of either supply voltage (for balanced bipolar supplies). Under this condition $P_{DL} = V_S^2 / (4 \times R_L)$ where R_L includes feedback network loading.

The power in the output stage and not into the load determines internal power dissipation.

As a worst-case example, compute the maximum T_J using the OPA817 in the circuit of Figure 8-1 operating at the maximum specified ambient temperature of +105°C and driving a grounded 100- Ω load.

$$P_D = 10 \text{ V} \times 23.5 \text{ mA} + 5^2 / (4 \times (100 \Omega \parallel 500 \Omega)) \cong 310 \text{ mW}$$

Maximum
$$T_J = 105^{\circ}C + (0.310 \text{ W} \times 64.9^{\circ}C/\text{W}) = 125.1^{\circ}C.$$

All actual applications operate at lower internal power and junction temperature.

Product Folder Links: OPA817



8.4.2 Layout Example

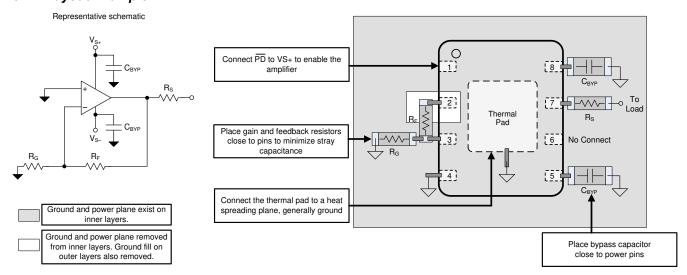


Figure 8-6. Layout Recommendation



9 Device and Documentation Support

9.1 Device Support

9.1.1 Development Support

Texas Instruments, Wide Bandwidth Optical Front-end Reference Design

9.2 Documentation Support

9.2.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, OPA817EVM User's Guide
- Texas Instruments, Transimpedance Considerations for High-Speed Amplifiers application report
- Texas Instruments, Maximizing the Dynamic Range of Analog TIA Front-End technical brief
- Texas Instruments, What You Need To Know About Transimpedance Amplifiers Part 1
- Texas Instruments, What You Need To Know About Transimpedance Amplifiers Part 2
- · Texas Instruments, Training Video: How to Design Transimpedance Amplifier Circuits
- Texas Instruments, Training Video: High-Speed Transimpedance Amplifier Design Flow

9.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.4 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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9.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Product Folder Links: OPA817



11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 23-May-2025

PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package Pins | Package qty Carrier | RoHS | Lead finish/ Ball material | MSL rating/ Peak reflow | Op temp (°C) | Part marking (6) |
|-----------------------|--------|---------------|----------------|-----------------------|------|-------------------------------|----------------------------|--------------|------------------|
| OPA817DTKR | Active | Production | WSON (DTK) 8 | 3000 LARGE T&R | Yes | (4) NIPDAU | (5) Level-2-260C-1 YEAR | -40 to 105 | 817 |
| OPA817DTKR.B | Active | Production | WSON (DTK) 8 | 3000 LARGE T&R | Yes | NIPDAU | Level-2-260C-1 YEAR | -40 to 105 | 817 |

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION



TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

| A0 | Dimension designed to accommodate the component width |
|----|---|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

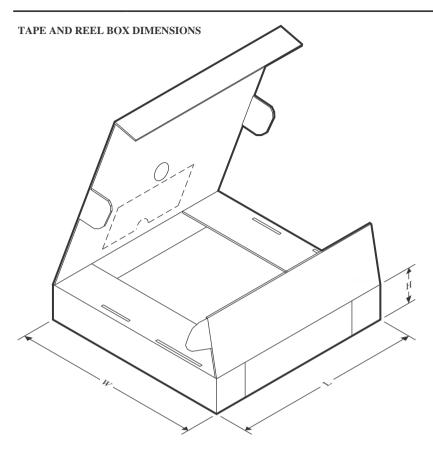


*All dimensions are nominal

| | Device | • | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---|------------|------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| ĺ | OPA817DTKR | WSON | DTK | 8 | 3000 | 330.0 | 12.4 | 3.3 | 3.3 | 1.1 | 8.0 | 12.0 | Q2 |

PACKAGE MATERIALS INFORMATION

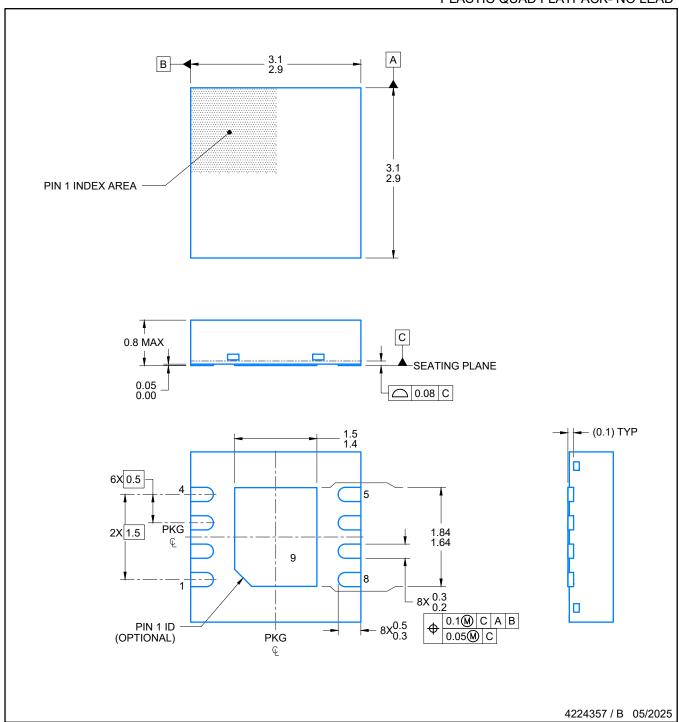
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*All dimensions are nominal

| Device Package Type | | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) | |
|---------------------|------|-----------------|------|------|-------------|------------|-------------|--|
| OPA817DTKR | WSON | DTK | 8 | 3000 | 367.0 | 367.0 | 35.0 | |

PLASTIC QUAD FLATPACK- NO LEAD

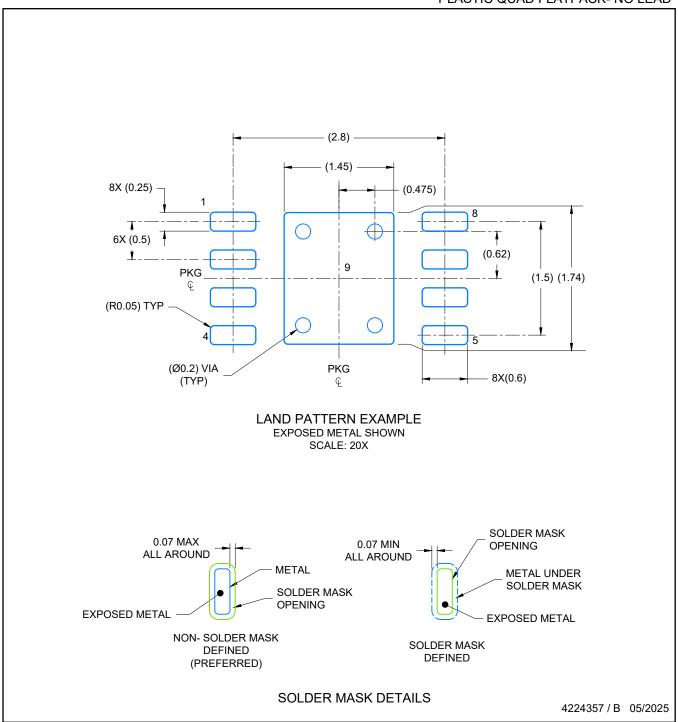


NOTES:

- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



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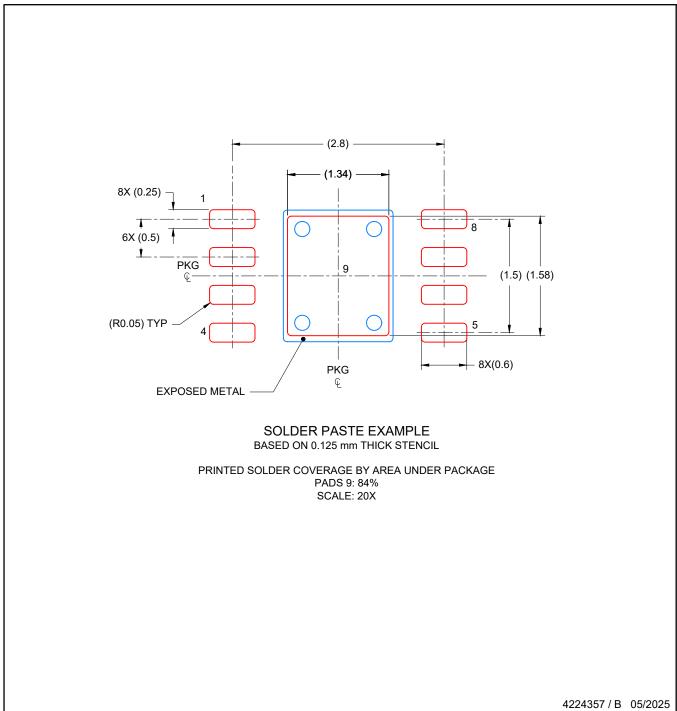


NOTES: (continued)

- 3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271) .
- 4. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC QUAD FLATPACK- NO LEAD



NOTES: (continued)

Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..



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